Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/815,528	CLARK ET AL.		
Examiner	Art Unit		
John S. Chu	1752		

SEARCHED										
Class	Subclass	Date	Examiner							
430	510	9/2007	Jsc							
430	512									
430	326									
430	314									
430	323									
430	324									
438	636	·\	V							
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INT	INTERFERENCE SEARCHED				
Class ·	Subclass	Date	Examiner		
430	510,512	9/2007	zsc		
430	326,314		1		
430	323,324				
438/	/636	J.			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
		DATE	EXMR	
updated		9/2007	zu	
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